High-electromechanical-coupling-coefficient and High-velocity Surface Acoustic Wave Materials of ZnO Films on Diamond

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Functional coatings are effective for improving the properties of devices. The development of thin-film-based surface acoustic wave (SAW) devices coated with piezoelectric zinc oxide (ZnO) thin films has attracted considerable attention. The orientation and thickness of piezoelectric films will affect the characteristics of SAW devices. In this research, (100) ZnO films were combined with diamond to form new composite SAW substrates. The SAW properties of (100) ZnO films on diamond with four composite structures, namely, interdigital transducer (IDT)/(100)ZnO/diamond, (100)ZnO/IDT/diamond, IDT/(100)ZnO/metal/diamond, and metal/(100)ZnO/IDT/diamond were systematically analyzed and some excellent SAW properties were observed. In particular, for mode 1 of (100)ZnO/IDT/diamond, a maximum $K^2$ of 5.85% and a maximum velocity of 8857 m/s were obtained at a minimum film thickness ratio of $h/\lambda = 0.11$. Such research results provide a predictable theoretical basis for the further application of such substrates in high-velocity SAW devices.

1. Introduction

Diamond is a non-piezoelectric material that requires a piezoelectric film to be deposited on top to excite surface acoustic waves (SAWs). A piezoelectric film on diamond is an attractive material for high-frequency SAW devices because the SAW velocity of diamond is the highest among all materials. Zinc oxide (ZnO) films have been widely investigated for application in SAW and film bulk acoustic wave devices because of their high piezoelectric coupling factor. There are many researchers preparing (002) ZnO films on diamond to excite SAWs (1–10) for high-frequency SAW devices. In particular, the commercialization of SAW devices based on the (002)ZnO/diamond structure has been developed by Sumitomo Electric Industries. (11,12)

Different orientations of piezoelectric films will form different acoustic properties. ZnO and AlN have the same crystalline structure. (100) AlN films on diamond exhibit excellent theoretical SAW properties compared with (002) AlN films on diamond. (13) (100) ZnO films can be deposited by different methods. (14–18) Bulk acoustic wave properties of (100) ZnO

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films have been reported, but their SAW properties were seldom studied. In our previous research, for the first time, (100) ZnO films were combined with diamond to form new high-frequency SAW substrates. The five Rayleigh SAW modes of the composite structure [interdigital transducer (IDT)/(100)ZnO/diamond] exhibited excellent SAW properties. For a composite thin-film SAW device, there are four basic structures, namely, IDT/(100)ZnO/diamond, (100)ZnO/IDT/diamond, IDT/(100)ZnO/metal/diamond, and metal/(100)ZnO/IDT/diamond. Different composite structures will exhibit different SAW properties. In this research, the first five SAW modes propagating in the four composite structures have been systematically analyzed, and such structures have been determined in high-velocity SAW devices.

2. Method of Analysis

The layered piezoelectric structure, as depicted in Fig. 1, consists of a ZnO film (h: film thickness) and diamond. Figure 1 shows a SAW propagating on the y–z plane for (100)ZnO/diamond. Following an approach similar to that developed by Campbell and Jones, the matrix method is effectively employed here to calculate the SAW velocity in a layered piezoelectric structure.

The acoustic and electric fields in mediums 1 and 2 can be expressed as

\[
u_j^{(1)} = \sum_{m=1}^{4} C_m a_j^{(m)} \exp(ikb^{(m)}z) \exp[ik(Px-vt)], \quad j = 1, 2, 3,
\]

\[
\phi^{(1)} = \sum_{m=1}^{4} C_m a_4^{(m)} \exp(ikb^{(m)}z) \exp[ik(Px-vt)],
\]

\[
u_j^{(2)} = \sum_{m=1}^{8} X_m \alpha_j^{(m)} \exp(ik\beta^{(m)}z) \exp[ik(Px-vt)],
\]

\[
u_j^{(2)} = \sum_{m=1}^{8} X_m \alpha_4^{(m)} \exp(ik\beta^{(m)}z) \exp[ik(Px-vt)],
\]

Fig. 1. Schematic of layered piezoelectric structure (100)ZnO/diamond.
where \( u \) is the acoustic displacement, \( \phi \) the electric potential, \( v \) the phase velocity, \( k \) the wave number in the \( x \)-direction, and \( P = 1 + i\gamma \), with \( \gamma \) being the attenuation coefficient; moreover, \( \beta \) is the wave number ratio, and \( \alpha \) the associated partial field amplitude. Substituting Eqs. (1) and (2) into stiffened Christoffel equations yields an eight-order algebraic equation for the wave number ratio \( b \). Thus, for each pair of \((v, \gamma)\) values, there are eight real or complex \( b \) values. For a semi-infinite piezoelectric crystal, i.e., medium 1 in this structure, four complex roots with negative imaginary parts are selected for the Rayleigh type. In medium 2, all eight roots of \( \beta \) are selected.

The boundary conditions require that the acoustic displacements and stresses be continuous at \( d = 0 \), and that the stress-free surface be assumed at \( d = h \). In addition, the electric potential and normal component of electric displacement must be continuous at the interface for an electrically free surface. For a metalized (thin metal film) surface, electric potential is not observed. By substituting Eqs. (1)–(4) into the boundary conditions, the phase velocity \( v \) and the attenuation coefficient \( \gamma \) can be obtained numerically. The electromechanical coupling coefficient \( (K^2) \) can be calculated from

\[
K^2 = 2 \frac{v_f - v_m}{v_f},
\]

where \( v_f \) and \( v_m \) are the phase velocities obtained when the electrical boundary conditions at the interface at which the IDT is placed are assumed to be electrically free and shorted, respectively. The material constants of ZnO and diamond employed here were obtained from the study reported by Gualtieri et al.\(^{(22)}\) and Benetti et al.\(^{(23)}\)

3. Results and Discussion

The phase velocity dispersion curves of the first five SAW modes propagating in the IDT/\( \text{ZnO/diamond} \) structure are shown in Fig. 2. The curves are plotted as functions of the film thickness ratio \((k/l)\) in Fig. 2. Calculated phase velocity dispersion curves of first five SAW modes propagating in the (100)ZnO/diamond structure.
thickness ratio \((h/\lambda)\), where \(h\) is the ZnO film thickness and \(\lambda\) is the wavelength. The phase velocity of each mode decreases as the film thickness ratio increases. For mode 0, the phase velocity originates from the SAW velocity of diamond \((10934 \text{ m/s})\) at \(h/\lambda = 0\). As the film thickness ratio \((h/\lambda)\) increases, the phase velocity decreases. At \(h/\lambda = 3\), the velocity of mode 0 is close to the SAW velocity of \((100)\) ZnO \((2508 \text{ m/s})\). Modes 1, 2, 3, and 4 show the cutoff at the critical point, where the phase velocity is close to the shear bulk wave velocity in diamond \((12323 \text{ m/s})\). Note that the phase velocity dispersion curve of mode 0 is very close to that of mode 1, and that the phase velocity dispersion curve of mode 3 is very close to that of mode 4, but do not cross. Instead of decreasing gradually, mode 0 bends up and mode 1 bends down at \(h/\lambda = 0.17\), and mode 3 bends up and mode 4 bends down at \(h/\lambda = 0.28\). This phenomenon was also observed in the \((002)\)ZnO/diamond structure, as mentioned in some earlier papers.(24,25)

The \(K^2\) dispersion curves of the first five Rayleigh-type modes propagating in the four composite structures are shown in Figs. 3–6. The \(K^2\) dispersion curves are calculated for the four composite structures as described below.

### 3.1. Electromechanical coupling coefficient dispersion curves of IDT/ZnO/diamond structure

The \(K^2\) dispersion curves of the IDT/(100)ZnO/diamond structure are shown in Fig. 3. For mode 0, the \(K^2\) curve shows an optimal value \((1.57\%)\) at \(h/\lambda = 0.15\) and the velocity is \(6670 \text{ m/s}\). For mode 1, \(K^2\) increases from \(0.05\%\) at \(h/\lambda = 0.06\). The \(K^2\) curve shows an optimal value \((4.28\%)\) at \(h/\lambda = 0.42\) and the velocity is \(5616 \text{ m/s}\). For mode 2, \(K^2\) increases from \(0.06\%\) at \(h/\lambda = 0.12\). The \(K^2\) curve shows an optimal value \((1.67\%)\) at \(h/\lambda = 0.81\) and the velocity is \(5409 \text{ m/s}\). For mode 3, \(K^2\) increases from \(0.002\%\) at \(h/\lambda = 0.22\). The \(K^2\) curve shows an optimal value \((1.7\%)\) at \(h/\lambda = 0.99\) and the velocity is \(5714 \text{ m/s}\). For mode 4, \(K^2\) increases from \(0.2\%\) at \(h/\lambda = 0.26\). The \(K^2\) curve shows an optimal value \((1.34\%)\) at \(h/\lambda = 1.32\) and the velocity is \(5641 \text{ m/s}\).

![Calculated \(K^2\) dispersion curves of first five Rayleigh SAW modes propagating in IDT/(100)ZnO/diamond.](image)
3.2 Electromechanical coupling coefficient dispersion curves of ZnO/IDT/diamond structure

The $K^2$ dispersion curves of the (100)ZnO/IDT/diamond structure are shown in Fig. 4. For mode 0, the $K^2$ curve shows an optimal value (3.25%) at $h/\lambda = 0.35$ and the velocity is 3676 m/s. For mode 1, $K^2$ increases from 1.03% at $h/\lambda = 0.06$. The $K^2$ curve shows an optimal value (5.85%) at $h/\lambda = 0.11$ and the velocity is 8587 m/s. For mode 2, $K^2$ increases from 0.04% at $h/\lambda = 0.12$. The $K^2$ curve shows an optimal value (0.69%) at $h/\lambda = 1.59$ and the velocity is 3894 m/s. For mode 3, $K^2$ increases from 0.002% at $h/\lambda = 0.12$. The $K^2$ curve shows an optimal value (1.88%) at $h/\lambda = 0.55$ and the velocity is 6748 m/s. For mode 4, $K^2$ increases from 0.15% at $h/\lambda = 0.26$. The $K^2$ curve shows an optimal value (0.83%) at $h/\lambda = 0.85$ and the velocity is 6694 m/s.

3.3 Electromechanical coupling coefficient dispersion curves of IDT/ZnO/metal/diamond structure

Figure 5 shows the $K^2$ dispersion curves of the IDT/(100)ZnO/metal/diamond structure. For mode 0, the $K^2$ curve shows an optimal value (1.33%) at $h/\lambda = 1.17$ and the velocity is 2564 m/s. For mode 1, $K^2$ increases from 1.32% at $h/\lambda = 0.06$. The $K^2$ curve shows the optimal value (4.15%) at $h/\lambda = 0.45$ and the velocity is 5529 m/s. For mode 2, $K^2$ increases from 0.06% at $h/\lambda = 0.12$. The $K^2$ curve shows an optimal value (1.7%) at $h/\lambda = 0.82$ and the velocity is 5389 m/s. For mode 3, $K^2$ increases from 0.001% at $h/\lambda = 0.22$. The $K^2$ curve shows an optimal value (1.69%) at $h/\lambda = 1$ and the velocity is 5703 m/s. For mode 4, $K^2$ increases from 0.33% at $h/\lambda = 0.26$. The $K^2$ curve shows an optimal value (1.34%) at $h/\lambda = 1.33$ and the velocity is 5623 m/s.

Fig. 4. Calculated $K^2$ dispersion curves of first five Rayleigh SAW modes propagating in (100)ZnO/IDT/diamond.

Fig. 5. Calculated $K^2$ dispersion curves of first five Rayleigh SAW modes propagating in IDT/(100)ZnO/metal/diamond.
3.4 Electromechanical coupling coefficient dispersion curves of metal/ZnO/IDT/diamond structure

Figure 6 shows the $K^2$ dispersion curves of the metal/(100)ZnO/IDT/diamond structure. For mode 0, the $K^2$ curve shows an optimal value (3.33%) at $h/\lambda = 0.36$ and the velocity is 3551 m/s. For mode 1, $K^2$ increases from 2.29% at $h/\lambda = 0.06$. The $K^2$ curve shows an optimal value (3.73%) at $h/\lambda = 0.17$ and the velocity is 6338 m/s. For mode 2, $K^2$ increases from 0.01% at $h/\lambda = 0.12$. The $K^2$ curve shows an optimal value (0.69%) at $h/\lambda = 1.7$ and the velocity is 3759 m/s. For mode 3, $K^2$ increases from 0 at $h/\lambda = 0.22$. The $K^2$ curve shows an optimal value (1.86%) at $h/\lambda = 0.56$ and the velocity is 6618 m/s. For mode 4, $K^2$ increases from 0.29% at $h/\lambda = 0.26$. The $K^2$ curve shows an optimal value (0.82%) at $h/\lambda = 0.85$ and the velocity is 6676 m/s.

![Fig. 6. Calculated $K^2$ dispersion curves of first five Rayleigh SAW modes propagating in metal/(100)ZnO/IDT/diamond.](image)

<table>
<thead>
<tr>
<th>Table 1</th>
<th>Relative maximum $K^2$ values of the first five modes propagating in the four structures.</th>
</tr>
</thead>
<tbody>
<tr>
<td>Propagation mode</td>
<td>Structure</td>
</tr>
<tr>
<td>Mode 0</td>
<td>(100)ZnO/IDT/diamond</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.35</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>1.17</td>
</tr>
<tr>
<td>metal/(100)ZnO/IDT/diamond</td>
<td>0.36</td>
</tr>
<tr>
<td>Mode 1</td>
<td>(100)ZnO/IDT/diamond</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.11</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.45</td>
</tr>
<tr>
<td>metal/(100)ZnO/IDT/diamond</td>
<td>0.17</td>
</tr>
<tr>
<td>Mode 2</td>
<td>(100)ZnO/IDT/diamond</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>1.59</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.82</td>
</tr>
<tr>
<td>metal/(100)ZnO/IDT/diamond</td>
<td>1.7</td>
</tr>
<tr>
<td>Mode 3</td>
<td>(100)ZnO/IDT/diamond</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.55</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>1</td>
</tr>
<tr>
<td>metal/(100)ZnO/IDT/diamond</td>
<td>0.56</td>
</tr>
<tr>
<td>Mode 4</td>
<td>(100)ZnO/IDT/diamond</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>0.85</td>
</tr>
<tr>
<td>(100)ZnO/metal/diamond</td>
<td>1.33</td>
</tr>
<tr>
<td>metal/(100)ZnO/IDT/diamond</td>
<td>0.85</td>
</tr>
</tbody>
</table>
Note that the $K^2$ dispersion curves change markedly at $h/\lambda = 0.17$ and 0.28, as shown in the insets in Figs. 3–6. In accordance with the rapid change in phase velocity, the $K^2$ dispersion curves change markedly. The $K^2$ dispersion curve of mode 0 decreases and the $K^2$ dispersion curve of mode 1 increases markedly at $h/\lambda = 0.17$. The $K^2$ dispersion curve of mode 3 increases and the $K^2$ dispersion curve of mode 4 decreases markedly at $h/\lambda = 0.28$. For the first five modes of the four structures, the relative maximum $K^2$ values are summarized in Table 1. It is obvious that mode 1 of the (100)ZnO/IDT/diamond structure has a maximum $K^2$ of 5.85% and a maximum velocity of 8857 m/s at a minimum film thickness ratio of $h/\lambda = 0.11$.

4. Conclusions

In this research, (100) ZnO films were combined with diamond to form new composite SAW substrates. The SAW properties of (100) ZnO films on diamond were systematically analyzed for four composite structures, namely, IDT/(100)ZnO/diamond, (100)ZnO/IDT/diamond, IDT/(100)ZnO/metal/diamond, and metal/(100)ZnO/IDT/diamond with excellent SAW properties. In particular, for mode 1 of (100)ZnO/IDT/diamond, a maximum $K^2$ of 5.85% and a maximum velocity of 8857 m/s were obtained at a minimum film thickness ratio of $h/\lambda = 0.11$. These research results provide a predictable theoretical basis for the further application of such substrates in high-velocity SAW devices.

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References


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